IXYS

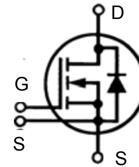
HiPerFET™ Power MOSFETs Single Die MOSFET

IXFE 39N90

V_{DSS} = 900 V
I_{D25} = 34 A
$R_{DS(on)}$ = 220 mΩ
t ≤ ns

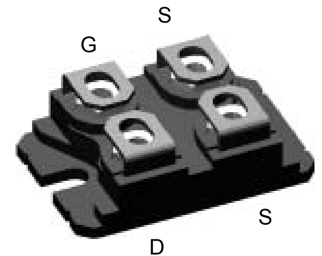
N-Channel Enhancement Mode
Avalanche Rated, High dv/dt, Low t_{rr}

Preliminary Data



Symbol	Test Conditions	Maximum Ratings	
V_{DSS}	T_J = 25°C to 150°C	900	V
V_{DGR}	T_J = 25°C to 150°C; R_{GS} = 1 MΩ	900	V
V_{GS}	Continuous	±20	V
V_{GSM}	Transient	±30	V
I_{D25}	T_C = 25°C, Chip capability	34	A
I_{DM}	T_C = 25°C, Note 1	154	A
I_{AR}	T_C = 25°C	39	A
E_{AR}	T_C = 25°C	64	mJ
E_{AS}	T_C = 25°C	4	J
dv/dt	I_S ≤ I_{DM}, di/dt ≤ 100 A/µs, V_{DD} ≤ V_{DSS} T_J ≤ 150°C, R_G = 2 Ω	5	V/ns
P_D	T_C = 25°C	580	W
T_J		-40 ... +150	°C
T_{JM}		150	°C
T_{stg}		-40 ... +150	°C
V_{ISOL}	50/60 Hz, RMS t = 1 min I_{ISOL} ≤ 1 mA t = 1 s	2500 3000	V~ V~
M_d	Mounting torque Terminal connection torque	1.5/13 1.5/13	Nm/lb.in. Nm/lb.in.

ISOPLUS 227™ (IXFE)



G = Gate D = Drain
S = Source

Either Source terminal at miniBLOC can be used as Main or Kelvin Source

Symbol	Test Conditions		Characteristic Values (T_J = 25°C, unless otherwise specified) min.	typ.	max.	
V_{DSS}	V_{GS} = 0 V, I_D = 3 mA		900			V
$V_{GH(th)}$	V_{DS} = V_{GS}, I_D = 8 mA		2.5		5.0	V
I_{GSS}	V_{GS} = ±20 V_{DC}, V_{DS} = 0				±200	nA
I_{DSS}	V_{DS} = V_{DSS} V_{GS} = 0 V	T_J = 25°C T_J = 125°C			100 2	µA mA
$R_{DS(on)}$	V_{GS} = 10 V, I_D = I_T Notes 2, 3				220	mΩ

Features
- Conforms to SOT-227B outline
- Low $R_{DS(on)}$ HDMOS™ process
- Rugged polysilicon gate cell structure
- Unclamped Inductive Switching (UIS) rated
- Low package inductance
- Fast intrinsic Rectifier

Applications
- DC-DC converters
- Battery chargers
- Switched-mode and resonant-mode power supplies
- DC choppers
- Temperature and lighting controls

Advantages
- Low cost
- Easy to mount
- Space savings
- High power density

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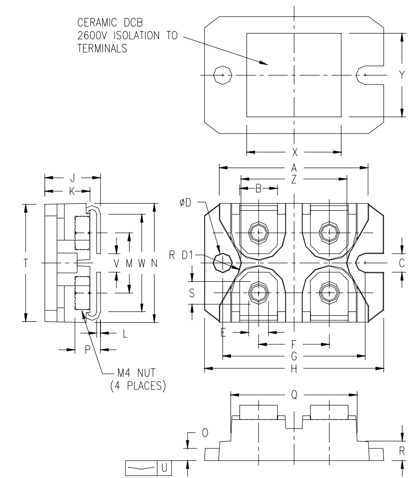
Symbol	Test Conditions	Characteristic Values (T_J = 25°C, unless otherwise specified) min.	typ.	max.	
g_{fs}	V_{DS} = 15 V; $I_D = I_T$, Note 2	30	45		S
C_{iss}	V_{GS} = 0 V, V_{DS} = 25 V, f = 1 MHz		13400		pF
C_{oss}			1230		pF
C_{rss}			320		pF
$t_{d(on)}$	V_{GS} = 10 V, $V_{DS} = 0.5 \bullet V_{DSS}$, $I_D = I_T$ R_G = 1 Ω (External),		45		ns
t_r			68		ns
$t_{d(off)}$			125		ns
t_f			30		ns
$Q_{g(on)}$	V_{GS} = 10 V, $V_{DS} = 0.5 \bullet V_{DSS}$, $I_D = I_T$		375		nC
Q_{gs}			75		nC
Q_{gd}			190		nC
R_{thJC}				0.22	K/W
R_{thCK}			0.07		K/W

Source-Drain Diode

Symbol	Test Conditions	Characteristic Values (T_J = 25°C, unless otherwise specified) min.	typ.	max.	
I_S	V_{GS} = 0 V			39	A
I_{SM}	Repetitive; Note 1			154	A
V_{SD}	$I_F = I_S$, V_{GS} = 0 V, Note 2			1.3	V
t_{rr}	I_F = 25A, -di/dt = 100 A/µs, V_R = 100 V			250	ns
Q_{RM}			2		µC
I_{RM}			9		A

Notes: 1. Pulse width limited by T_{JM}.
2. Pulse test, t ≤ 300 ms, duty cycle d ≤ 2%.
3. I_T Test current: I_T = 19.5 A

ISOPLUS-227 B



SYM	INCHES MIN	INCHES MAX	MILLIMETERS MIN	MILLIMETERS MAX
A	1.240	1.270	31.50	32.26
B	.310	.330	7.87	8.38
C	.155	.165	3.94	4.19
D	.155	.165	3.94	4.19
D1	.150	.157	3.81	3.98
E	.160	.168	4.06	4.27
F	.587	.595	14.91	15.11
G	1.186	1.193	30.12	30.30
H	1.489	1.505	37.80	38.23
J	.465	.481	11.81	12.22
K	.370	.380	9.40	9.65
L	.030	.033	0.76	0.84
M	.496	.506	12.60	12.85
N	.990	1.001	25.15	25.42
O	.100	.105	2.54	2.67
P	.195	.235	4.95	5.97
Q	1.045	1.059	26.54	26.90
R	.160	.170	4.06	4.32
S	.186	.191	4.72	4.85
T	.968	.987	24.59	25.07
U	-.001	.002	-0.03	0.05
V	.130	.160	3.30	4.06
W	.780	.830	19.81	21.08
X	.770	.810	19.56	20.57
Y	.680	.720	17.27	18.29
Z	.885	.892	22.48	22.66

Please see IXFN39N90 data sheet for characteristic curves.

IXYS reserves the right to change limits, test conditions, and dimensions.